Giant electrostatic modification of magnetism via electrolyte-gate-induced cluster percolation in La$_{1-x}$Sr$_x$CoO$_{3-\delta}$

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Abstract
Electrical control of magnetism is a long-standing goal in science and technology, with the potential to enable a next generation of low-power memory and logic devices. Recently developed electrolyte gating techniques provide a promising route to realization, although the ultimate limits on modulation of magnetic properties remain unknown. Here, guided by a recent theoretical prediction, we demonstrate large enhancement of electrostatic modulation of ferromagnetic order in ion-gel-gated ultrathin films of the perovskite La\(_{0.5}\)Sr\(_{0.5}\)CoO\(_3-\delta\) by thickness tuning to the brink of percolation. Application of only 3–4 V is then shown capable of inducing a clear percolation transition from a short-range magnetically ordered insulator to a robust long-range ferromagnetic metal with perpendicular magnetic anisotropy. This realizes giant electrostatic Curie temperature modulation over a 150 K window, outstanding values for both complex oxides and electrolyte gating. *In operando* polarized neutron reflectometry confirms gate-controlled ferromagnetism, additionally demonstrating, surprisingly, that electrostatically induced magnetic order can penetrate substantially deeper than the Thomas-Fermi screening length.

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The electric field effect, wherein electric fields applied across a dielectric induce a controlled density of two-dimensional (2D) charge carriers in a conductor, has played a major role in science and technology. This is the principle of operation of the metal-oxide-semiconductor field-effect transistor (MOSFET), also being widely used in research for the modulation of electronic properties. This is the principle of operation of the metal-oxide-semiconductor field-effect transistor (MOSFET), also being widely used in research for the modulation of electronic properties. This is the principle of operation of the metal-oxide-semiconductor field-effect transistor (MOSFET), also being widely used in research for the modulation of electronic properties.

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Electrical control of magnetism is a long-standing goal in science and technology, with the potential to enable a next generation of low-power memory and logic devices. Recently developed electrolyte gating techniques provide a promising route to realization, although the ultimate limits on modulation of magnetic properties remain unknown. Here, guided by a recent theoretical prediction, we demonstrate large enhancement of electrostatic modulation of ferromagnetic order in ion-gel-gated ultrathin films of the perovskite $\text{La}_{0.5}\text{Sr}_{0.5}\text{CoO}_3$–δ by thickness tuning to the brink of percolation. Application of only 3–4 V is then shown capable of inducing a clear percolation transition from a short-range magnetically ordered insulator to a robust long-range ferromagnetic metal with perpendicular magnetic anisotropy. This realizes giant electrostatic Curie temperature modulation over a 150 K window, outstanding values for both complex oxides and electrolyte gating. In operando polarized neutron reflectometry confirms gate-controlled ferromagnetism, additionally demonstrating, surprisingly, that electrostatically induced magnetic order can penetrate substantially deeper than the Thomas-Fermi screening length.

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formation enthalpy and diffusivity of $V_{O}$ [24,26]. Critically, electrochemical control at $V_{G} > 0$ resulted in La$_{0.7}$Sr$_{0.3}$CoO$_{3}$ $T_{C}$ shifts of $\sim$200 K in $\pm$3 V [24] (although reversibility remains to be studied in depth), while electrostatic operation at $V_{G} < 0$ resulted in a $T_{C}$ shift of only 12 K in $-4$ V [26].

A natural question is thus how electrostatic control of magnetic order in such materials can be optimized. Importantly, many of these materials (La$_{1-x}$Sr$_{x}$CoO$_{3}$—LSCO) [37–39], La$_{1-x}$Sr$_{x}$MnO$_{3}$ [40], etc.) evolve from inhomogeneous states to uniform FM with doping. In LSCO for example, Sr$^{2+}$ creates formally Co$^{4+}$ ions that nucleate hole-rich non-FM clusters in an insulating non-FM matrix (essentially a superparamagnetic state), eventually percolating into a long-range FM metal at $x_{C} = 0.18$ [37–39]. One attractive concept [Fig. 1(a)] is then to chemically dope to the brink of a percolation IMT [note the finite clusters (green) in Fig. 1(a)], and then electrostatically gate across the transition, potentially generating anomalously large increases in $T_{C}$, magnetization, and conductivity. This combined bulk chemical and surface electrostatic doping was considered in our recent percolation theory [41], resulting in Fig. 1(b). Solid lines here show the 2D surface charge densities (per Co) required to achieve percolation ($\Delta s_{c}$) vs the starting effective chemical doping ($x_{eff}$), for multiple thicknesses ($t$). (We use $x_{eff}$ here due to finite $V_{O}$ concentration in La$_{1-x}$Sr$_{x}$CoO$_{3}$, which compensates Sr doping; in the simplest picture, $x_{eff} = x - 28$ [42]). Independent of thickness, $\Delta s_{c}$ at $x_{eff} = 0$ is 0.5, the expected 2D value [43]. As $x_{eff}$ increases, $\Delta s_{c}$ first decreases linearly before dropping rapidly as the ($t$-dependent) bulk percolation threshold is approached [43]. Considering that an experimentally achievable $\Delta s_{c}$ in a perovskite EDLT is $\sim$0.1 [shaded region, Fig. 1(b)], the steepness of $\Delta s_{c}$ near three-dimensional (3D) bulk percolation (black line) means that tuning $x_{eff}$ to the brink of percolation in thick films would require unreasonable compositional control. As also shown in Fig. 1(b), however, $\Delta s_{c}(x_{eff})$ at low thickness shows a progressively shallower approach to percolation. At 2 u.c., for example, an achievable $\Delta s_{c} \approx 0.1$ enables percolation at 0.23 $< x_{eff} < 0.27$, a 400 times wider window than 3D. Thickness tuning to the brink of percolation followed by electrolyte gating is thus predicted as a promising means to optimize electrostatic control of magnetism.

Here, we first test these predictions through transport studies of LSCO EDLTSs vs $x_{eff}$ and thickness ($t_{expt}$). Guided by theory, thickness tuning is indeed established as an ideal means to tune to the brink of a percolation IMT, 6 u.c. proving optimal. Ion-gel gating of 6-u.c. films of $x = 0.5$ LSCO is then shown to enable electrostatic tuning from a short-range-ordered insulator to a long-range FM metal, spanning a 150 K $T_{C}$ range with only $-4$ V. The induced FM is robust, with 1 T coercivity, high remanence, and perpendicular anisotropy. This 150 K window is enhanced over an order of magnitude
compared to prior electrostatic tuning in LSCO [26], establishing giant electrostatic modulation of $T_C$ and outstanding $\Delta T_C$ values for electrolyte gating and complex oxides. In operando polarized neutron reflectometry (PNR) not only confirms FM, but also establishes deeper penetration of induced magnetization than the Thomas-Fermi screening length, with significant implications for devices.

Epitaxial LSCO EDLTs utilizing solid-state ion-gel electrolytes based on 1-ethyl-3-methylimidazolium bis(trifluoromethylsulfonyl) imide ionic liquid were prepared and characterized [24,26], as detailed in the Supplemental Material, Sec. A (Fig. S1) [44]. Throughout this Rapid Communication, only negative $V_g$s are applied, utilizing electrostatic (not electrochemical) gating. Transport and PNR details are provided in the Supplemental Material, Sec. B [44]. Figures 1(c)–1(e) first show the effect of varying $x_{\text{eff}}$ while keeping $t_{\text{expt}}$ approximately constant at 8–12 u.c., i.e., the thick-film limit in this system, where dead layer effects are weak [45]. Starting at $x = 0.50$ [Fig. 1(e)], as in prior work [26], the temperature ($T$) dependence of resistivity ($\rho$) [46] displays clearly metallic behavior, well beyond the percolation IMT. Applying $V_g = -4 V$ decreases the low-$T$ resistivity by $\sim 18\%$ via hole doping, the inflection point at 162–174 K evidencing the previously reported 12 K $T_C$ shift, confirmed by anomalous Hall effect (AHE) [26]. The impact of decreasing chemical doping is shown in Figs. 1(d) and 1(c), for $x = 0.22$ and 0.15. Progressively more insulating behavior is observed, as expected, but without a $V_g$-induced IMT. At $x = 0.15$, for example, insulating $\rho(T)$ occurs, but application of $-4 V$, while generating a tenfold low-$T$ resistivity decrease, is incapable of inducing percolation. As illustrated in Figs. 1(e)–1(g), fixing $x = 0.50$ and reducing $t_{\text{expt}}$ (from 8 to 5 u.c.) is far more effective in tuning to the brink of percolation. In particular, at 6 u.c., initially insulating $\rho(T)$ occurs, but with application of $-4 V$ driving a tenfold decrease in low-$T$ resistivity, to a state with positive $d\rho/dT$. This is shown more clearly (on a linear $\rho$ scale) in Fig. 2(a), Supplemental Material, Sec. C (Fig. S2) [44] confirming finite $T \rightarrow 0$ conductivity at finite $V_g$. A gate-induced percolative IMT is thus realized in LSCO EDLTs, via the predicted route of thickness tuning.

Figure 1(b) shows that these results are at least qualitatively consistent with our theory. The colored points here (right axis) show the achieved electrostatic doping ($\Delta x_{\text{expt}}$, per Co) as a function of $x_{\text{eff}}$, for various experimental thicknesses, $t_{\text{expt}}$. As detailed in Supplemental Material, Sec. D [44], $x_{\text{eff}}$ and $\Delta x_{\text{expt}}$ are determined by comparison to LSCO single crystal $\rho(T, x)$ (Figs. S3 and S4 [44]). The $x = 0.15$ film in Fig. 1(c), for example, has $x_{\text{eff}} = 0.11$ [black point, Fig. 1(b)], the achieved $\Delta x_{\text{expt}} = 0.11$ falling well below the $\Delta x_c = 0.33$ required to reach percolation, consistent with the $V_g$ dependence in Fig. 1(c). The situation is very different for $x = 0.50$, however. The determined $x_{\text{eff}}$ here, in the thick-film limit, is 0.22, consistent with the metallic $\rho(T)$ [Fig. 1(e)]. Although quantitative comparisons between theoretical and experimental thickness dependences are complicated by dead layers (Supplemental Material, Sec. E, Fig. S5 [44]), decreasing $t_{\text{expt}}$ from 8 to 6 u.c. does significantly increase $\Delta x_{\text{expt}}$ [to 0.18, Fig. 1(b)], realizing $\Delta x_{\text{expt}} > \Delta x_c$, even when comparing to the extreme limit of 2 u.c. (red line).

Importantly, Fig. 2 demonstrates that the gate-induced IMT in these 6-u.c. LSCO films also drives a transition from a short-range magnetically clustered state to a long-range FM metal. Initial evidence comes from Fig. 2(a), where positive $d\rho/dT$ emerges at $V_g \leq -3 V$, accompanied by inflection near 150 K; in LSCO, such inflection points strongly suggest FM order [26,39]. More direct evidence comes from the AHE, as in Fig. 2(d). Shown here is the $5 K$ magnetic flux density ($B$) dependence of the transverse conductivity ($\sigma_{xy} = \rho_{xy}/\rho_{zz}^2$), where $\rho_{xy}$ is the transverse resistivity and $\rho_{zz}$ is the $B = 0$ longitudinal $\rho$, revealing a remarkable evolution with $V_g$. At $V_g = 0$ and $-1 V$ no AHE is detected, but at $V_g = -2 V$ weak AHE emerges, growing into a large, hysteretic effect by $-3, -4 V$. This is strong evidence for long-range FM, electrostatically induced from a non-FM starting point. Notably, the gate-induced FM is robust, exhibiting $1 T$ coercivity, remanence of $60\%$ of saturation, and strong perpendicular magnetic anisotropy. The latter is a feature of LSCO under compressive strain [47], the large anomalous Hall conductivity leading to $\sigma_{xy}(B)$ dominated by magnetism [26]. Setting a small out-of-plane $B = 0.02 T$ and measuring $\sigma_{xy}(T)$ then enables an order-parameter measurement. As shown in Fig. 2(c), $\sigma_{xy}(T)$ reveals negligible FM at 0 and $-1 V$, a minor increase at the lowest $T$ at $-2 V$, but strong FM order at $-3, -4 V$. The low-$T$ downturn in $\sigma_{xy}(T)$ may reflect the upturn in $\rho(T)$ [Fig. 2(a)], or $T$-dependence competition between in-plane and perpendicular anisotropy [26]. Regardless, order-parameter behavior occurs at high $T$, directly demonstrating $T_C$ up to $150 K$ at $-4 V$. The electrostatically induced $T_C$ shift by thickness tuning to the brink of percolation in LSCO is thus $150 K$, over an order of magnitude above the previous 12 K [26].

Magnetoresistance (MR) measurements support these conclusions. Shown in Fig. 2(b) is the $T$ dependence of $MR = [\rho(T, B) - \rho(T, B_z)]/\rho(T, B_z)$, where $B_z$ is the coercive field, and $B$ is fixed, out of plane, at 9 T. At $V_g = 0$, the MR magnitude simply increases monotonically on cooling, reaching $-30\%$ at low $T$. As shown in Figs. 2(d) and 2(e), this is due to an isotropic, negative, hysteretic MR, with peaks at $\pm B_z$. This is well known in LSCO, arising due to spin-dependent intercluster transport on the insulating side of the IMT, i.e., intergranular giant magnetoresistance [38,39]. This is therefore exactly as expected in a subpercolative (superparamagnetic) starting film. As the magnitude of $V_g$ is increased, however, this low-$T$ isotropic MR is weakened, while a high-$T$ MR turns on, around the induced $T_C$ [Fig. 2(b)]. This is also typical for LSCO, arising due to the spin-disorder MR known to exist around $T_C$ in the long-range FM metallic phase [38,39]. As shown in Figs. 2(d) and 2(e), the low-$T$ MR in the gate-induced FM metallic state additionally becomes more anisotropic than at low $V_g$ (by a factor of $\sim 3$), due to the onset of anisotropic magnetoresistance (AMR) [48]. The $V_g$ dependence of MR($B, T$) is therefore in excellent agreement with a gate-induced transition from a magnetically clustered (superparamagnetic) insulator to a long-range FM metal.

A succinct summary of the evolution with $V_g$ is provided in Figs. 2(g)–2(i). As $V_g$ decreases from 0 to $-4 V$ the low-$T$ resistivity falls by over an order of magnitude, driven by electrostatic hole accumulation [Fig. 2(g)]. The $T$-dependent measurements described above confirm this is due to a percolation IMT. Accompanying the IMT, the MR evolves...
from a state dominated by isotropic low-\(T\) intercluster MR [Fig. 2(h), left axis] to a state with substantial MR near \(T_C\) due to field-induced suppression of spin disorder [Fig. 2(h), right axis], as well as low-\(T\) AMR [Figs. 2(d) and 2(e)]. This confirms the percolation transition from a nanoscopic magnetically clustered state (essentially superparamagnetic) to a true long-range-ordered FM metal. Finally, and most directly, as \(V_g\) is decreased below \(-2\) V strong AHE turns on [Fig. 2(i), left axis], the deduced \(T_C\) increasing from 0 to 150 K.

While this transport evidence for gate-induced percolation to an FM state is strong, in \textit{operando} PNR was also performed, seeking confirmation of long-range FM, as well as the depth profile of the induced magnetization, \(M\). The latter is important, as our recent theory predicts anomalously deep magnetic SLD at \(V_g=0\), but \(M=0\) at all \(z\), confirming no long-range FM. At \(V_g=-3\) V, however, good fits can only be achieved with finite magnetic SLD, the best-fit \(M(z)\) being shown in Fig. 3(c) (right axis). Remarkably, \(M\) is quite uniform with depth, the maximum value being 0.34 \(\mu_B/\text{Co}\), and the magnetic and nuclear roughnesses being identical. To put this in context, at \(T_C \approx 150\) K, bulk LSCO has \(M \approx 0.8 \mu_B/\text{Co}\) [37]. This LSCO film has perpendicular anisotropy, however, which is not entirely overcome by the available in-plane \(B = 1\) T; we thus expect \(M < 0.8 \mu_B/\text{Co}\), consistent with experiment. Importantly, and as elaborated upon in the Supplemental Material, Sec. G (Fig. S6) [44], alternative \(M(z)\) profiles weighted towards the LSCO surface can be excluded. Our best-fit \(M(z)\) in fact extends significantly deeper than the induced carrier profile from Thomas-Fermi calculations, which indicate 90% carrier confinement in the top 2.5 u.c. (Fig. S6). This result further validates our recent percolation theory, occurring due to gate-mediated connection of...
existing finite clusters that penetrate the film thickness, i.e., surface-assisted bulk percolation [Fig. 1(a)] [41]. Importantly, this demonstrates that electrostatic modulation of magnetism need not be confined to extreme surface regions, which is highly significant for future device design.

In summary, using ion-gel-based epitaxial LSCO EDLTs, and guided by recent theory, thorough verification of the efficacy of thickness tuning to approach the verge of a percolation IMT has been achieved. At an optimal thickness of 6 u.c., a gate-induced transition from an insulating magnetically clustered state to a long-range FM metal is demonstrated by transport and PNR. This enables giant electrostatic $T_C$ modulation of 150 K, dramatically increased over the prior 12 K. This 150 K electrostatic shift is outstanding for electrolyte-gated materials, as well as for complex oxides gated by any electrostatic means [49–52]. Our work thus brings electrostatically induced $T_C$ shifts into the same realm as electrochemical $T_C$ shifts, but with potential advantages in speed and reversibility. Future efforts with higher-$T_C$ materials could even realize such $T_C$ shifts around room temperature, creating FMs with electrically tunable thermal stability. Importantly, the principles in this work can be employed generally, to any of the many systems undergoing magnetic percolation.

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[43] $x_{\text{eff}}$ and $\Delta T_c$ values in Fig. 1(b) have been scaled compared to Ref. [41]. The latter considered site percolation, where the percolation thresholds are 0.31 (3D) and 0.59 (2D). The observed threshold in bulk LSCO is 0.18, however, consistent with 3D continuum percolation. We thus scaled the axes of Fig. 1(b) to match threshold values for continuum percolation, i.e., 0.18 (3D) and 0.50 (2D). Universality near the 2D and 3D thresholds justifies this; the steep increase of $\Delta T_c$ near $x_c$ is governed by the correlation length exponent [41], which is identical for lattice and continuum percolation.
[45] These $x = 0.5$ LSCO films are deposited on (001) LaAlO$_3$ and SrLaAlO$_3$ substrates, where ferromagnetic metallic behavior occurs down to 8 u.c. thickness [26]. Further discussion of dead layers is given in the Supplemental Material, Secs. A and E [44].
[46] Resistivity is simply determined from sheet resistance and thickness, i.e., assuming depthwise-uniform $\rho$. While gate-induced changes may not traverse the entire thickness, relative comparisons of $\rho(T)$ among different $V_{GS}$ remain valid.
[49] The only comparable comparison of $x_{\text{eff}}$ and $\Delta T_c$ values in Fig. 1(b) have been scaled compared to Ref. [41]. The latter considered site percolation, where the percolation thresholds are 0.31 (3D) and 0.59 (2D). The observed threshold in bulk LSCO is 0.18, however, consistent with 3D continuum percolation. We thus scaled the axes of Fig. 1(b) to match threshold values for continuum percolation, i.e., 0.18 (3D) and 0.50 (2D). Universality near the 2D and 3D thresholds justifies this; the steep increase of $\Delta T_c$ near $x_c$ is governed by the correlation length exponent [41], which is identical for lattice and continuum percolation.